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APPLICATION NO.	F	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/779,749	02/18/2004		Yoshihiro Kimura	H6808.0040/P040	2045
24998	7590	11/27/2006	EXAMINER		INER
DICKSTEIN SHAPIRO LLP 1825 EYE STREET NW				JOHNSTON, PHILLIP A	
	Washington, DC 20006-5403				PAPER NUMBER
•				2881	
				DATE MAIL ED: 11/27/2006	

Please find below and/or attached an Office communication concerning this application or proceeding.

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)⊠ Responsive to communication(s) filed on <u>23 August 0200</u> .)□ This action is FINAL . 2b)⊠ This action is non-final.						
3)☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
parte Quayle, 1935 C.D. 11, 45	53 O.G. 213.					
from consideration. ection requirement.						
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Detailed Action

1. This Office Action is submitted in response to the RCE/ amendment filed 8-23-2006, wherein claims 1,2,3, 10, and 11have been amended. Claims 1-11 are pending.

Claims Rejection - 35 U.S. C. 102

- 2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:
 - (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
 - 3. Claims 1-11 are rejected under 35 U.S.C. 102 (b) as being clearly anticipated by Archie, U. S. Patent No. 5,969,273.
- 4. Regarding claim 11, Archie teaches the use of an SEM (charged particle source) to perform an e-beam scan (scanning deflector) across a resist line (Col. 5, line 36-47), forming a profile waveform of the detected electron signal (Col. 5, line 36-47) with processor 402 (Col. 5, line 3-5). Archie also teaches comparing the absolute value of the slope (comparison means) in regions on either side the peak locations of the waveform to determine the "humpwidth" of the resist line (Column 6, line 9-3) relative to the baseline of the waveform. Archie further teaches computing the derivative of the waveform 700, to determine the slope, and selecting the points at which the difference between the slope and the maximum slope (determination means) reaches a threshold value (Col. 6, line 23-28). Thus, since all the structural limitations

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recited in claim 11 are anticipated by Archie, and the determination means of claim 11 is directed to a result or property of the Archie structure then claim 11 is anticipated by Archie. In re May.

- 5. Regarding claims 1,2, and 10, the rational applied above regarding claim 11, also applies to the structural limitations of claims 1,2, and 10.
- 6. Regarding claims 3 and 4 the rational applied above regarding claims 1,2, and 10 also applies to claims 3 and 4. Archie also teaches the beam scanning perpendicular to the sample. Note Figure 6A.
- 7. Regarding claim 5, the rational applied above regarding claims 1,2, and 10, also applies to claim 5.
- 8. Regarding claim 6, the rational applied above regarding claims 1,2, and 10, also applies to claim 6.
- 9. Regarding claim 7, the rational applied above regarding claim 6, also applies to claim 7. In addition, Archie teaches comparing waveform measurements to edge width or "humpwidth" threshold levels (a pre-registered model).
- 10. Regarding claims 8 and 9, the rational applied above regarding claim 6, also applies to claims 8 and 9.

Conclusion

11. Any inquiry concerning this communication or earlier communications should be directed to Phillip Johnston whose telephone number is (571) 272-2475. The examiner

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can normally be reached on Monday-Friday from 7:30 am to 4:00 pm. If attempts to reach the examiner by telephone are unsuccessful, the examiners supervisor Drew Dunn can be reached at (571)272-2312. The fax phone number for the organization where the application or proceeding is assigned is 571 273 8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

November 17, 2006